MOSFET – Power, Single N-Channel, D2PAK

650 V, 110 mΩ, 30 A

NVB110N65S3F

Description

SUPERFET[®] III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate.

Consequently, SUPERFET III MOSFET is very suitable for the various power system for miniaturization and higher efficiency. SUPERFET III FRFET[®] MOSFET's optimized reverse recovery performance of body diode can remove additional component and improve system reliability.

Features

- 700 V @ $T_J = 150^{\circ}C$
- Typ. $R_{DS(on)} = 93 \text{ m}\Omega$
- Ultra Low Gate Charge (Typ. Q_g = 58 nC)
- Low Effective Output Capacitance (Typ. Coss(eff.) = 533 pF)
- 100% Avalanche Tested
- Qualified with AEC-Q101
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

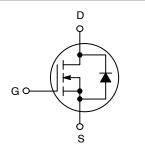
- Automotive On Board Charger
- Automotive DC/DC Converter for HEV



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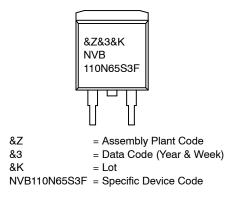
| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX | |
|----------------------|-------------------------|--------------------|--|
| 650 V | 110 m Ω @ 10 V | 30 A | |



N-CHANNEL MOSFET



MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

| Symbol | Parameter | Value | Unit | |
|-----------------------------------|---|---------------------------------------|------------|------|
| V _{DSS} | Drain-to-Source Voltage | 650 | V | |
| V _{GS} | Gate-to-Source Voltage | – DC | ±30 | V |
| | | – AC (f > 1 Hz) | ±30 | |
| Ι _D | Drain Current | – Continuous (T _C = 25°C) | 30 | А |
| | | – Continuous (T _C = 100°C) | 19.5 | |
| I _{DM} | Drain Current | – Pulsed (Note 1) | 69 | А |
| E _{AS} | Single Pulse Avalanche Energy (Note 2) | | 380 | mJ |
| I _{AS} | Avalanche Current | | 3.5 | А |
| E _{AR} | Repeated Avalanche Energy (Note 1) | 2.4 | mJ | |
| dv/dt | dv/dt MOSFET dv/dt | | 100 | V/ns |
| | Peak Diode Recovery dv/dt (Note 3) | 50 | | |
| PD | Power Dissipation | TC = 25°C | 240 | W |
| | | – Derate Above 25°C | 1.92 | W/°C |
| T _J , T _{stg} | Operating Junction and Storage Temperature | | -55 to 150 | °C |
| ΤL | Maximum Lead Temperature for Soldering, 1/8" from | 300 | °C | |

Table 1. ABSOLUTE MAXIMUM RATINGS (T_C = 25° C unless otherwise stated)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive rating: pulse – width limited by maximum junction temperature. 2. IAS = 3.5 A, RG = 25 Ω , starting T_J = 25°C. 3. ISD ≤ 15 A, di/dt ≤ 200 A/_s, V_{DD} ≤ 400 V, starting T_C = 25°C.

Table 2. THERMAL RESISTANCE RATINGS

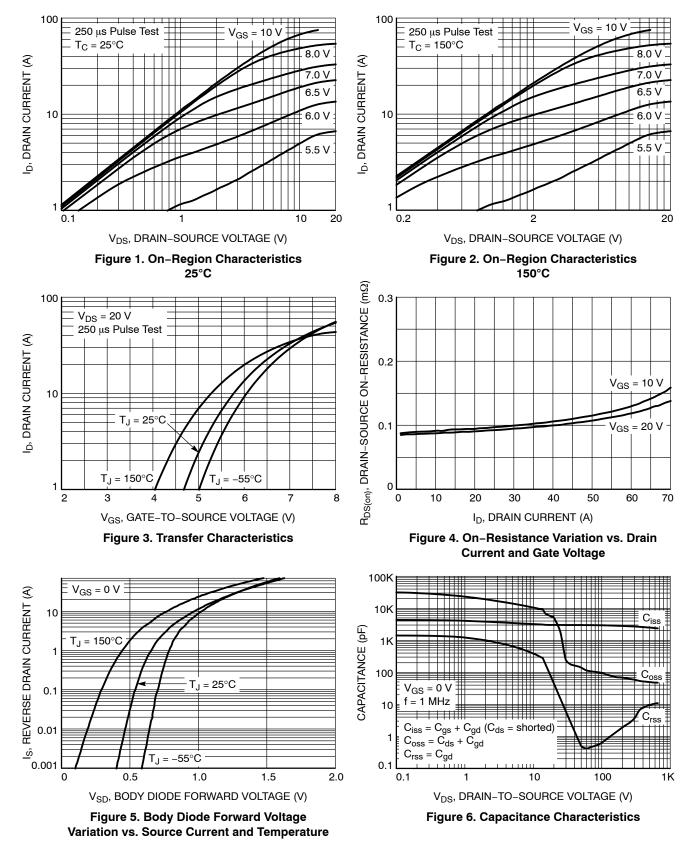
| Symbol | Parameter | Мах | Unit |
|-----------------------|---|------|------|
| $R_{	extsf{	heta}JC}$ | Thermal Resistance, Junction-to-Case, Max. | 0.52 | °C/W |
| R_{\thetaJA} | Thermal Resistance, Junction-to-Ambient, Max. | 40 | |

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

| Symbol | Parameter Test Conditions | | Min | Тур | Max | Unit |
|--|--|--|-----|------|------|------|
| OFF CHARAC | TERISTICS | | | • | | |
| BV _{DSS} | Drain-to-Source Breakdown Voltage | V_{GS} = 0 V, I_D = 1 mA, T_J = 25°C | 650 | - | - | V |
| | | V_{GS} = 0 V, I_D = 10 mA, T_J = 150°C | 700 | - | - | V |
| $\Delta \text{BV}_{\text{DSS}} / \Delta \text{T}_{\text{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = 20 mA, Referenced to 25°C | - | 0.61 | - | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 650 \text{ V}, V_{DS} = 0 \text{ V}$ | - | - | 10 | μΑ |
| | | V_{DS} = 520 V, T_{C} = 125°C | - | 128 | - | μA |
| I _{GSS} | Gate-to-Body Leakage Current | V_{GS} = 0 V, I_D = 1 mA, T_J = 25°C | - | - | ±100 | nA |
| ON CHARACT | ERISTICS | | | | - | - |
| V _{GS(th)} | Gate Threshold Voltage | V_{GS} = V_{DS} , I_D = 0.74 mA | 3.0 | - | 5.0 | V |
| R _{DS(on)} | Static Drain-to-Source On Resistance | V _{GS} = 10 V, I _D = 15 A | - | 93 | 110 | mΩ |
| 9FS | Forward Transconductance | V_{GS} = 20 V, I_{D} = 15 A | - | 17 | - | S |
| DYNAMIC CH | ARACTERISTICS | | | | | |
| C _{iss} | Input Capacitance | V_{DS} = 400 V, V_{GS} = 0 V, f = 1 MHz | - | 2560 | - | pF |
| C _{oss} | Output Capacitance | | - | 50 | _ | pF |
| C _{oss(eff.)} | Effective Output Capacitance | V_{DS} = 0 to 400 V, V_{GS} = 0 V | - | 553 | - | pF |
| C _{oss(er.)} | Energy Related Output Capacitance | V_{DS} = 0 to 400 V, V_{GS} = 0 V | - | 83 | - | pF |
| Q _{g(total)} | Total Gate Charge at 10 V | V _{DS} = 400 V, I _D = 15 A, | - | 58 | - | nC |
| Q _{gs} | Gate-to-Source Gate Charge | V _{GS} = 10 V (Note 4) | - | 19 | - | nC |
| Q _{gd} | Gate-to-Drain "Miller" Charge | | - | 23 | - | nC |
| ESR | Equivalent Series Resistance | F = 1 MHz | - | 2 | - | Ω |
| SWITCHING C | HARACTERISTICS, V _{GS} = 10 V | | | | - | - |
| t _{d(on)} | Turn-On Delay Time | $V_{DD} = 400 \text{ V}, \text{ I}_{D} = 15 \text{ A},$ | - | 29 | - | ns |
| t _r | Rise Time | V _{GS} = 10 V, R _G = 4.7 Ω (Note 4) | - | 32 | - | ns |
| t _{d(off)} | Turn-Off Delay Time | | - | 61 | - | ns |
| t _f | Fall Time | | - | 16 | - | ns |
| SOURCE-DR | AIN DIODE CHARACTERISTICS | | | | | |
| I _S | Maximum Continuous Source-to-Drain Diode Forward Current | | | - | 30 | Α |
| I _{SM} | Maximum Pulsed Source-to-Drain Diode Forward Current | | | - | 69 | Α |
| V _{SD} | Source-to-Drain Diode Forward Voltage | V_{GS} = 0 V, I_{SD} = 15 A | - | - | 1.3 | V |
| t _{rr} | Reverse–Recovery Time | $V_{GS} = 0 V, I_{SD} = 15 A,$ | _ | 94 | - | ns |
| Q _{rr} | Reverse-Recovery Charge | dI _F /dt = 100 A/μs | _ | 343 | _ | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Essentially independent of operating temperature typical characteristics.

TYPICAL CHARACTERISTICS



10 1.2 BREAKDOWN VOLTAGE (Normalized) 60 0.1 1.1 7.1 8 60 0.1 1.1 7.1 V_{DS} = 130 V V_{GS}, GATE-SOURCE VOLTAGE (V) $V_{GS} = 0 V$ 9 I_D = 15 A I_D = 10 mA BV_{DSS}, DRAIN-TO-SOURCE 8 7 V_{DS} = 400 V 6 5 4 3 2 1 0 0.8 10 20 30 40 50 60 -75 -25 25 75 125 175 0 Q_G, TOTAL GATE CHARGE (nC) TJ, JUNCTION TEMPERATURE (°C) Figure 7. Gate Charge Characteristics Figure 8. Breakdown Voltage Variation vs. Temperature 100 3.0 R_{DS(on)}, DRAIN-SOURCE ON-RESISTANCE (Normalized) 1 1 5 5 5 5 $I_D = 15 A$ V_{GS} = 10 V 100 µs ID, DRAIN CURRENT (A) 10 R_{DS(on)} Limit m 0 ms 1 $T_C = 25^{\circ}C$ $R_{\theta JC} = 0.52^{\circ}C/W$ Single Pulse 100 ms/DC 1 1 1 1 1 0 0.1 -75 25 -25 75 125 175 10 100 1000 1 TJ, JUNCTION TEMPERATURE (°C) V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 9. On-Resistance Variation vs. Figure 10. Maximum Safe Operating Area Temperature 40 15.0 12.5 ID, DRAIN CURRENT (A) 30 10.0 (Lu) SSO3 20 7.5 5.0 10 2.5 0 0 75 50 100 125 150 100 200 300 400 500 600 25 0 T_C, CASE TEMPERATURE (°C) V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

TYPICAL CHARACTERISTICS

Figure 11. Maximum Drain Current vs. Case Temperature Figure 12. E_{OSS} vs. Drain-to-Source Voltage

TYPICAL CHARACTERISTICS

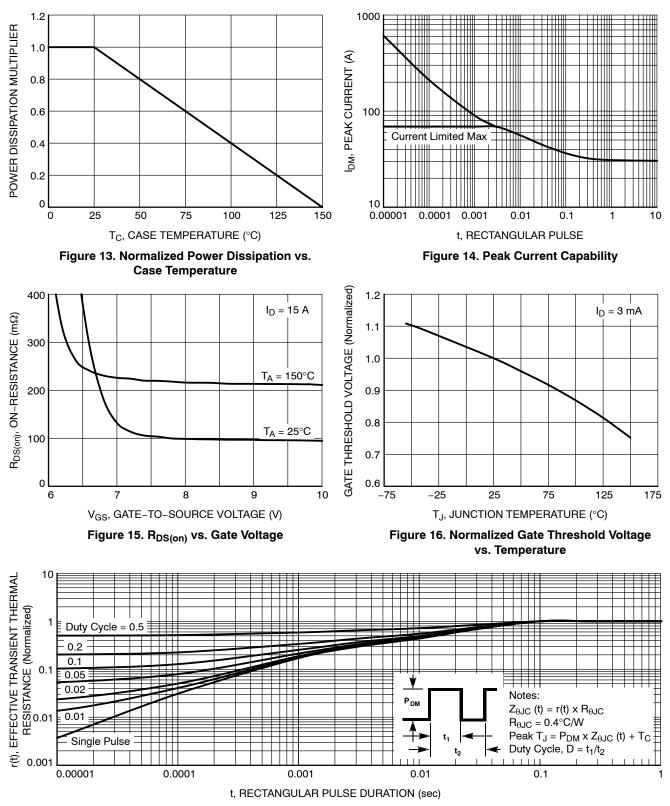


Figure 17. Transient Thermal Response

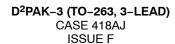
PACKAGE MARKING AND ORDERING INFORMATION

| Part Number | Top Marking | Package | Packing Method | Reel Size | Tape Width | Quantity |
|--------------|--------------|--------------------|--------------------------|-----------|------------|-----------|
| NVB110N65S3F | NVB110N65S3F | D ² PAK | Tape & Reel [†] | 330 mm | 24 mm | 800 Units |

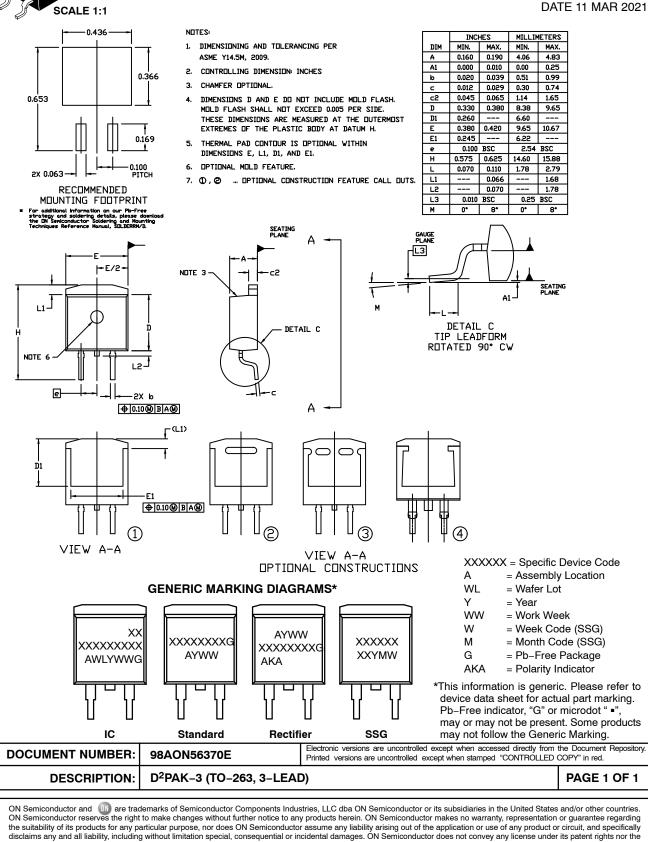
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.

MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS









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